

## CLAIMS

1. (Cancelled)
2. (Previously presented) A measurement system comprising:  
a first log amp;  
a second log amp; and  
a differencing circuit coupled to the first and second log amps, wherein the differencing circuit is arranged to continuously process outputs from the first and second log amps;  
wherein the first and second log amps are progressive compression log amps.
3. (Previously presented) A measurement system according to claim 2 wherein:  
the first log amp has a first logarithmic output coupled to a first input to the differencing circuit; and  
the second log amp has a second logarithmic output coupled to a second input to the differencing circuit.
4. (Previously presented) A measurement system comprising:  
a first log amp;  
a second log amp; and  
a differencing circuit coupled to the first and second log amps, wherein the differencing circuit consists essentially of a summing node.
5. (Previously presented) A measurement system according to claim 2 wherein the differencing circuit comprises an output interface circuit.
6. (Previously presented) A measurement system comprising:  
a first log amp;  
a second log amp;  
a differencing circuit coupled to the first and second log amps; and  
a phase detector core coupled to the first and second log amps.
7. (Original) A measurement system according to claim 6 wherein:

the first log amp has a first limiting output coupled to a first input of the phase detector core; and

the second log amp has a second limiting output coupled to a second input of the phase detector core.

8. (Original) A measurement system according to claim 7 wherein the detector core comprises a multiplier.

9. (Original) A measurement system according to claim 6 further comprising an output interface circuit coupled to the phase detector core.

10. (Previously presented) A measurement system comprising:  
a first log amp; and  
a second log amp;  
wherein the first and second log amps are progressive compression log amps co-integrated on a substrate.

11. (Previously presented) A measurement system comprising:  
a first log amp; and  
a second log amp;  
wherein the first and second log amps are co-integrated on a substrate; and  
wherein the first and second log amps are arranged symmetrically about a center line.

12. (Original) A measurement system circuit according to claim 10 wherein the substrate is mounted in a package.

13. (Previously presented) A measurement system comprising:  
a first log amp;  
a second log amp;  
a first parasitic network coupled to the first log amp; and  
a second parasitic network coupled to the second log amp;  
wherein the first and second log amps are co-integrated on a substrate;  
wherein the substrate is mounted in a package; and  
wherein the first and second parasitic networks have similar frequency responses.

14. (Previously presented) A measurement system comprising:  
a first log amp;  
a second log amp;  
a differencing circuit having first and second inputs coupled to the first and second log amps, respectively; and  
a third log amp coupled to a third input of the differencing circuit.

15. (Previously presented) A measurement system comprising:  
a first log amp;  
a second log amp;  
a differencing circuit having first and second inputs coupled to the first and second log amps, respectively; and  
one or more additional log amps coupled to one or more additional inputs of the differencing circuit.

16. (Original) A measurement system comprising:  
a first log amp having a first limiting output;  
a second log amp having a second limiting output; and  
a phase detector core coupled to the first and second log amps to receive the first and second limiting outputs.

17. (Original) A measurement system according to claim 16 wherein the phase detector core comprises a multiplier.

18. (Original) A measurement system according to claim 16 wherein the first and second log amps are co-integrated on a substrate.

19. (Previously presented) An integrated circuit comprising two or more progressive compression log amps.

20. (Previously presented) An integrated circuit according to claim 19 further comprising a differencing circuit coupled to the two or more progressive compression log amps.

21. (Previously presented) An integrated circuit comprising:  
two or more log amps  
a differencing circuit coupled to the two or more log amps; and  
a phase detector core coupled to the two or more log amps.
22. (Previously presented) A method comprising:  
logarithmically amplifying a first input signal, thereby generating a first output signal;  
logarithmically amplifying a second input signal, thereby generating a second output  
signal; and  
differentially and continuously processing the first and second output signals;  
wherein logarithmically amplifying comprises progressively compressing.
23. (Original) A method according to claim 22 wherein:  
the first and second output signals are logarithmic output signals; and  
differentially processing the first and second output signals comprises differencing the  
first and second output signals.
24. (Previously presented) A method comprising:  
logarithmically amplifying a first input signal, thereby generating a first output signal;  
logarithmically amplifying a second input signal, thereby generating a second output  
signal; and  
differentially processing the first and second output signals  
wherein:  
the first and second output signals are limiting output signals; and  
differentially processing the first and second output signals comprises  
multiplying the first and second output signals.
25. (Previously presented) A method comprising:  
logarithmically amplifying a first input signal, thereby generating a first output signal;  
logarithmically amplifying a second input signal, thereby generating a second output  
signal;  
differentially processing the first and second output signals;  
utilizing a signal to be examined as the first input signal; and  
utilizing a reference signal as the second input signal.

26. (Original) A method according to claim 25 wherein the reference signal has the same waveform as the signal to be examined.

27. (Previously presented) A method comprising:  
logarithmically amplifying a first input signal, thereby generating a first output signal;  
logarithmically amplifying a second input signal, thereby generating a second output signal;  
differentially processing the first and second output signals;  
utilizing a modulated signal for the first input signal; and  
utilizing a modulation signal for the second input signal.

28. (Previously presented) A measurement system according to claim 2 further comprising a power amplifier having an input coupled to an input of the first log amp and an output coupled to an input of the second log amp.

29. (Previously presented) A measurement system according to claim 4 wherein the log amps have current-mode outputs.

30. (New) A measurement system comprising:  
a first log amp;  
a second log amp; and  
a differencing circuit coupled to the first and second log amps, wherein the differencing circuit is arranged to continuously process outputs from the first and second log amps;  
wherein the first and second log amps comprise progressive compression log amps.

31. (New) A measurement system comprising:  
a first log amp; and  
a second log amp;  
wherein the first and second log amps comprise progressive compression log amps co-integrated on a substrate.